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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit		
V _{DS}	Drain-source voltage	80	V		
V_{GS}	Gate-source voltage	±20	V		
In ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	180			
ID ^(*)	Drain current (continuous) at T _C = 100 °C		А		
I _{DM} ⁽²⁾	Drain current (pulsed)	720	Α		
Ртот	Total dissipation at T _C = 25 °C 315				
Eas ⁽³⁾	Single pulse avalanche energy	0.775	J		
T _{stg}	Storage temperature range				
Tj	Operating junction temperature range				

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.48	900
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb	35	°C/W

Notes:

⁽¹⁾ When mounted on FR-4 board of 1 inch2, 2oz Cu.



⁽¹⁾ Limited by package.

 $^{^{\}left(2\right) }$ Pulse width is limited by safe operating area.

 $^{^{(3)}}$ Starting $T_j = 25~^{\circ}C,~I_d = 65~A,~V_{dd} = 50~V,~T_j < T_{j\text{-max}}.$

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4: On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	80			V
	Zoro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 80 \text{ V}$			1	
I _{DSS} Zero gate voltage drain current		$V_{GS} = 0 \text{ V}, V_{DS} = 80 \text{ V},$ $T_{C} = 125 \text{ °C} (1)$			100	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V}$			100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2.5		4.5	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 90 A		1.7	2.1	mΩ

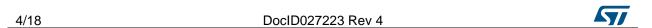
Notes:

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		•	13600	1	
Coss	Output capacitance	$V_{DS} = 50 \text{ V, } f = 1 \text{ MHz,}$	ı	2050	ı	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	236	-	ρı
Qg	Total gate charge	$V_{DD} = 40 \text{ V}, I_D = 180 \text{ A},$	-	193	-	
Qgs	Gate-source charge	VGS = 10 V	•	96	1	nC
Q_{gd}	Gate-drain charge	(see Figure 14: "Test circuit for gate charge behavior")	-	46	-	

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V _{DD} = 40 V, I _D = 90 A	1	56	1	
tr	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$	ı	180	ı	no
t _{d(off)}	Turn-off delay time	(see Figure 18: "Switching time waveform")	ı	98	ı	ns
t _f	Fall time		-	42	-	



⁽¹⁾ Defined by design, not subject to production test.

Table 7: Source-drain diode

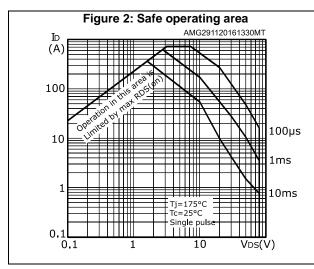
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isp	Source-drain current		-		180	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		720	Α
V _{SD} ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 90 A	-		1.2	V
t _{rr}	Reverse recovery time		-	78		ns
Qrr	Reverse recovery charge	$I_{SD} = 180 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$ $V_{DD} = 64 \text{ V}, T_i = 150 ^{\circ}\text{C}$	-	182		nC
I _{RRM}	Reverse recovery current	= 01 v, 1 _j = 100 0	-	4.7		Α

Notes:

 $^{^{\}left(1\right) }$ Pulse width limited by safe operating area.

 $^{^{(2)}}$ Pulsed: pulse duration = 300 $\mu s,$ duty cycle 1.5 %.

2.1 Electrical characteristics (curves)



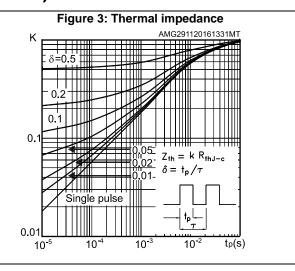
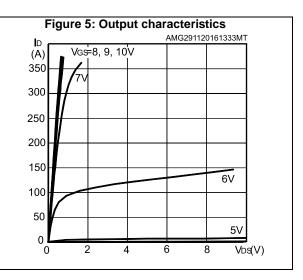
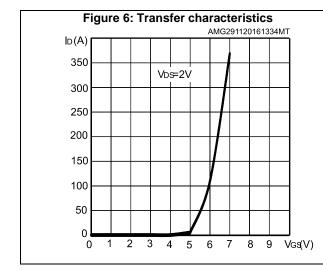
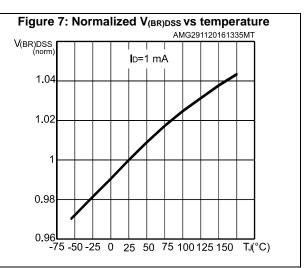


Figure 4: Gate charge vs gate-source voltage

VGS
(V)
12
10
10
8
6
4
2
0
0
50
100
150
200
Qg(nC)







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Figure 8: Static drain-source on-resistance

RDS(on) (mOhm)

1.74

1.72

1.70

1.68

1.66

0 20 40 60 80 100 120 140 160 180 lb(A)

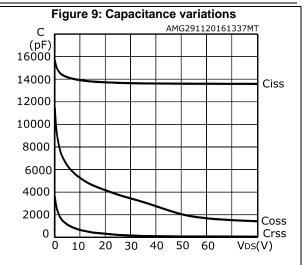


Figure 10: Source-drain diode forward characteristics

VSD (V)

1

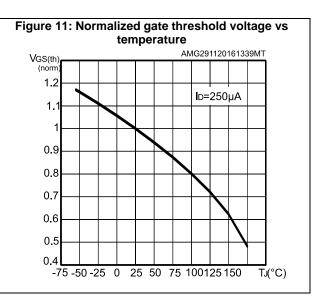
TJ=-50°C

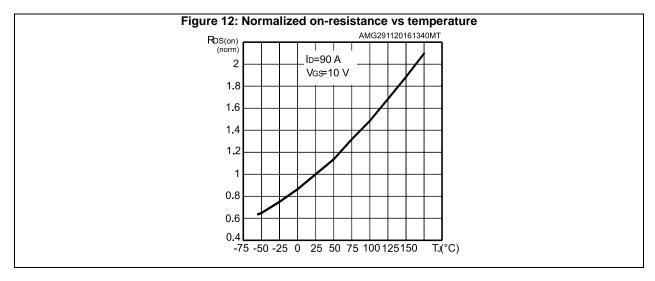
0.7

0.6

0.5

0 20 40 60 80 100 120 140 160 ISD(A)







3 Test circuits

Figure 13: Test circuit for resistive load switching times

Figure 14: Test circuit for gate charge behavior

12 V 47 KΩ 100 Ω D.U.T.

12 V 47 KΩ VGD

14 VGD

14 VGD

14 VGD

15 VGD

16 CONST

100 Ω OVG

17 VGD

18 VGD

18 VGD

18 VGD

18 VGD

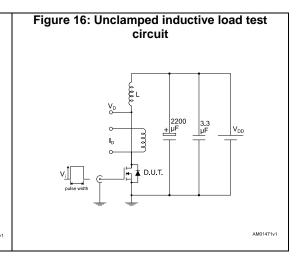
18 VGD

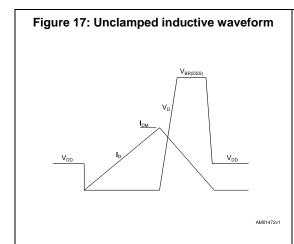
18 VGD

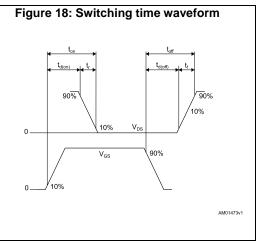
19 VGD

10 VGD

Figure 15: Test circuit for inductive load switching and diode recovery times







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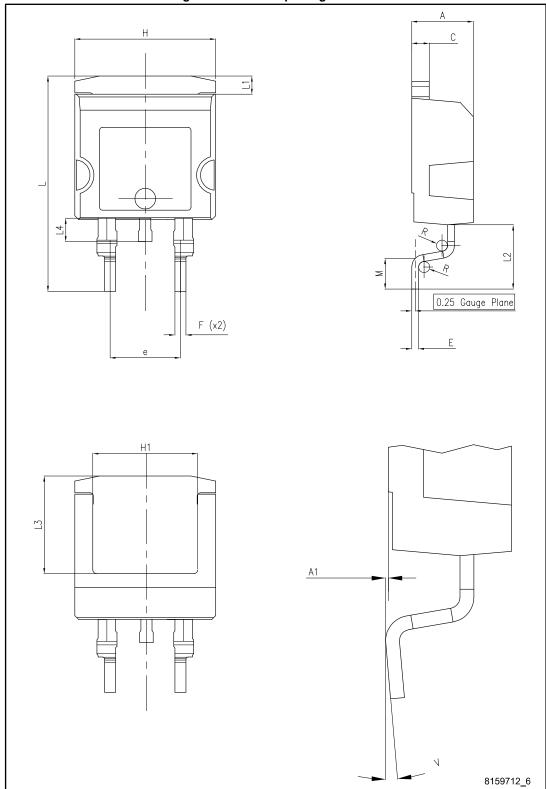
4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



4.1 H²PAK-2 package information

Figure 19: H²PAK-2 package outline

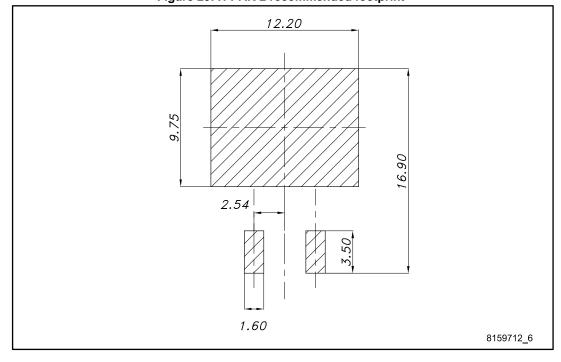


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Table 8: H²PAK-2 package mechanical data

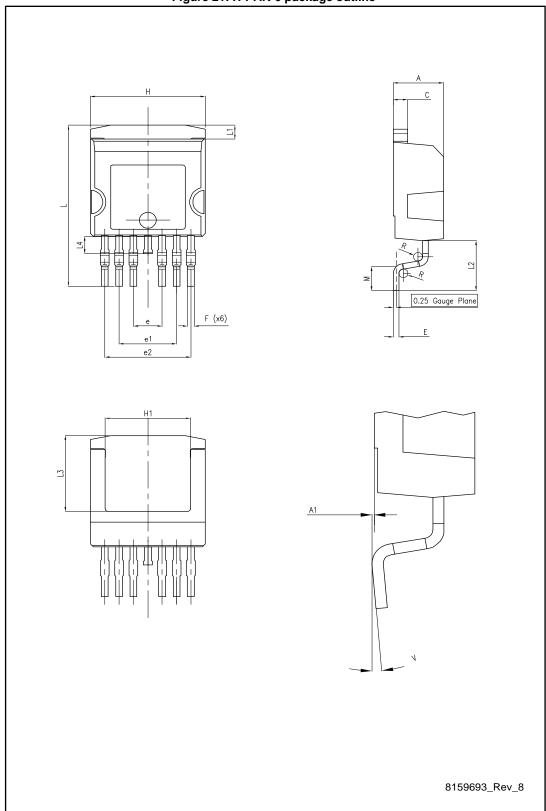
Dim	Tuble 6. ITT AR 2 publ	mm	
Dim.	Min.	Тур.	Max.
А	4.30		4.70
A1	0.03		0.20
С	1.17		1.37
е	4.98		5.18
Е	0.50		0.90
F	0.78		0.85
Н	10.00		10.40
H1	7.40		7.80
L	15.30	-	15.80
L1	1.27		1.40
L2	4.93		5.23
L3	6.85		7.25
L4	1.5		1.7
M	2.6		2.9
R	0.20		0.60
V	0°		8°

Figure 20: H²PAK-2 recommended footprint



4.2 H²PAK-6 package information

Figure 21: H²PAK-6 package outline



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Table 9: H²PAK-6 package mechanical data

	Table 9. ITT AN-0 pack	mm				
Dim.	Min.	Тур.	Max.			
А	4.30		4.70			
A1	0.03		0.20			
С	1.17		1.37			
е	2.34	2.54	2.74			
e1	4.88		5.28			
e2	7.42		7.82			
E	0.45		0.60			
F	0.50		0.70			
Н	10.00		10.40			
H1	7.40		7.80			
L	14.75		15.25			
L1	1.27		1.40			
L2	4.35		4.95			
L3	6.85		7.25			
L4	1.50		1.75			
М	1.90		2.50			
R	0.20		0.60			
V	0°		8°			

Figure 22: H²PAK-6 recommended footprint 12.20 0.80 5.08

7.62



Dimensions are in mm.

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footprint_Rev_8

4.3 H²PAK packing information

Figure 23: Tape outline

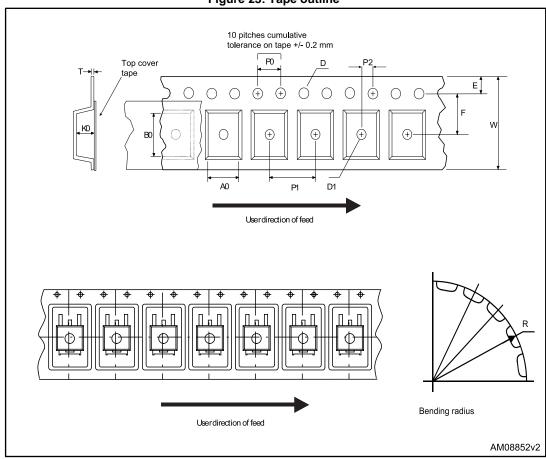
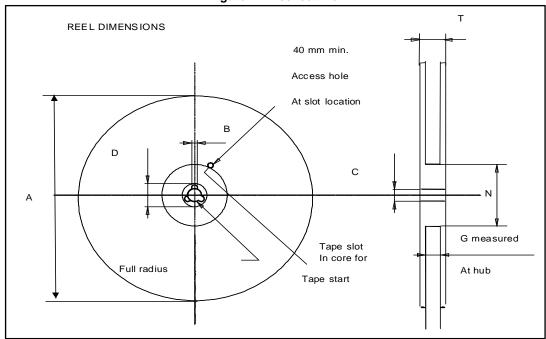


Figure 24: Reel outline





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Table 10: Tape and reel mechanical data

	Tape			Reel	
Dim.	mm		Dim	mm	
Dim.	Min.	Max.	Dim.	Min.	Max.
A0	10.5	10.7	А		330
В0	15.7	15.9	В	1.5	
D	1.5	1.6	С	12.8	13.2
D1	1.59	1.61	D	20.2	
E	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	Т		30.4
P0	3.9	4.1			
P1	11.9	12.1	Base q	uantity	1000
P2	1.9	2.1	Bulk qı	uantity	1000
R	50				
Т	0.25	0.35			
W	23.7	24.3			

5 Revision history

Table 11: Document revision history

Date	Revision	Changes	
27-Nov-2014	1	First release.	
05-Mar-2015	2	Document status promoted from preliminary to production data. Updated title and feature in cover page.	
10-Mar-2016	3	Updated Table 4. Minor text changes.	
10-Jan-2017	4	Updated title and features in cover page. Updated Table 2: "Absolute maximum ratings", Table 4: "On/off states" and Table 6: "Switching times". Minor text changes.	

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